Product Preview

N-Channel Power MOSFET 600 V, 15 Ω

Features

- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

ABSOLUTE MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	NDD	NDT	Unit
Drain-to-Source Voltage	V_{DSS}	600		V
Continuous Drain Current $R_{\theta JC}$ Steady State, T_C = 25°C (Note 1)	Ι _D	0.8	0.3	Α
Continuous Drain Current $R_{\theta JC}$ Steady State, T_C = 100°C (Note 1)	Ι _D	0.5	0.15	Α
Pulsed Drain Current, t _p = 10 μs	I_{DM}	3.2	1.0	Α
Power Dissipation $-R_{\theta JC}$ Steady State, $T_C = 25^{\circ}C$	P_{D}	25	3	W
Gate-to-Source Voltage	V _{GS}	±30		V
Single Pulse Drain-to-Source Avalanche Energy (I _{PK} = 1.0 A)	EAS	60		mJ
Peak Diode Recovery (Note 2)	dv/dt	4.5		V/ns
Source Current (Body Diode)	IS	0.5	0.3	Α
Lead Temperature for Soldering Leads	TL	260		°C
Operating Junction and Storage Temperature	T _J , T _{STG}	–55 to	+150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Limited by maximum junction temperature
- 2. $I_S = 1.5 \text{ Å}, \text{ di/dt} \le 100 \text{ A/}\mu\text{s}, \text{ V}_{DD} \le \text{BV}_{DSS}$

THERMAL RESISTANCE

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) NDDL1N60Z	$R_{\theta JC}$	5	°C/W
Junction-to-Ambient (Note 4) NDDL1N60Z (Note 3) NDDL1N60Z-1 (Note 4) NDTL1N60Z (Note 5) NDTL1N60Z	$R_{ hetaJA}$	50 96 62 151	°C/W

- 3. Insertion mounted.
- 4. Surface-mounted on FR4 board using 1" sq. pad size (Cu area = 1.127" sq. [2 oz] including traces).

 5. Surface–mounted on FR4 board using minimum recommended pad size
- (Cu area = 0.026" sq. [2 oz]).

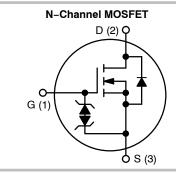
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V _{(BR)DSS}	R _{DS(ON)} MAX
600 V	15 Ω @ 10 V



MARKING DIAGRAMS

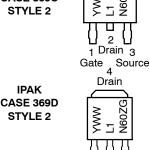
Drain



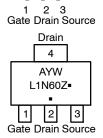
DPAK CASE 369C STYLE 2

IPAK

STYLE 2



= Year ww = Work Week = Pb-Free Package



W

SOT-223 **CASE 318E** STYLE 3

Assembly Location = Year

= Work Week 01N60 = Specific Device Code = Pb-Free Package

(*Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise noted)

Characteristic	Symbol	Test Condition	ıs	Min	Тур	Max	Unit
OFF CHARACTERISTICS			•			•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA		600			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	Reference to 25°C, I _D	, = 1 mA		660		mV/°C
Drain-to-Source Leakage Current	I _{DSS}	V _{DS} = 600 V, V _{GS} = 0 V	T _J = 25°C			1	μΑ
			T _J = 125°C			50	1
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} = ±20 V	•			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS} = V_{GS}$, $I_D = 5$	0 μΑ	3	3.75	4.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				7.0		mV/°C
Static Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 0).2 A		13	15	Ω
Forward Transconductance	9FS	V _{DS} = 15 V, I _D = 0).2 A		0.5		S
CHARGES, CAPACITANCES & GATE R	ESISTANCES						
Input Capacitance (Note 7)	C _{iss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz			94		pF
Output Capacitance (Note 7)	C _{oss}				18		7
Reverse Transfer Capacitance (Note 7)	C _{rss}				3		
Total Gate Charge (Note 7)	Q_g	V _{DS} = 300 V, I _D = 0.4 A, V _{GS} = 10 V			5		nC
Gate-to-Source Charge (Note 7)	Q_{gs}				1		
Gate-to-Drain Charge (Note 7)	Q_gd				3		
Plateau Voltage	V_{GP}				6		V
Gate Resistance	R_g				TBD		Ω
SWITCHING CHARACTERISTICS (Note	8)						
Turn-on Delay Time	t _{d(on)}				6		ns
Rise Time	t _r	V _{DD} = 300 V, I _D = 0).4 A,		5		
Turn-off Delay Time	t _{d(off)}	$V_{DD} = 300 \text{ V, } I_D = 0$ $V_{GS} = 10 \text{ V, } R_G = 0$	0 Ω		13		
Fall Time	t _f	1			25		
DRAIN-SOURCE DIODE CHARACTERI	STICS		•			•	
Diode Forward Voltage	V_{SD}	$I_S = 0.4 \text{ A}, V_{GS} = 0 \text{ V}$ $T_J = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$			0.8	1.6	V
					0.6		1
Reverse Recovery Time	t _{rr}		•		140		ns
Charge Time	ta	$V_{GS} = 0 \text{ V}, V_{DD} = 30 \text{ V}$ $I_{S} = 0.8 \text{ A}, d_{i}/d_{t} = 100 \text{ A}/\mu\text{s}$			25		1
Discharge Time	t _b				115		1
Reverse Recovery Charge	Q _{rr}				220		nC

- 6. Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 7. Guaranteed by design.8. Switching characteristics are independent of operating junction temperatures.

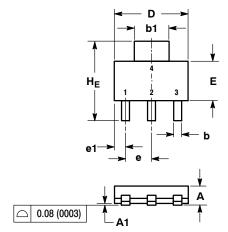
ORDERING INFORMATION

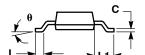
Device	Package	Shipping [†]
NDDL1N60Z-1G	IPAK (Pb-Free, Halogen-Free)	75 Units / Rail
NDDL1N60ZT4G	DPAK (Pb-Free, Halogen-Free)	2500 / Tape & Reel
NDTL1N60ZT1G	SOT-223 (Pb-Free, Halogen-Free)	1000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

SOT-223 (TO-261) CASE 318E-04 ISSUE N



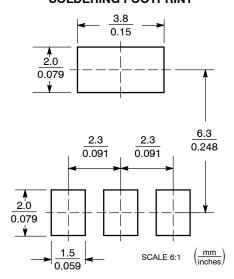


- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCH.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.50	1.63	1.75	0.060	0.064	0.068
A1	0.02	0.06	0.10	0.001	0.002	0.004
b	0.60	0.75	0.89	0.024	0.030	0.035
b1	2.90	3.06	3.20	0.115	0.121	0.126
С	0.24	0.29	0.35	0.009	0.012	0.014
D	6.30	6.50	6.70	0.249	0.256	0.263
E	3.30	3.50	3.70	0.130	0.138	0.145
е	2.20	2.30	2.40	0.087	0.091	0.094
e1	0.85	0.94	1.05	0.033	0.037	0.041
L	0.20			0.008		
L1	1.50	1.75	2.00	0.060	0.069	0.078
HE	6.70	7.00	7.30	0.264	0.276	0.287
θ	0°	_	10°	0°	-	10°

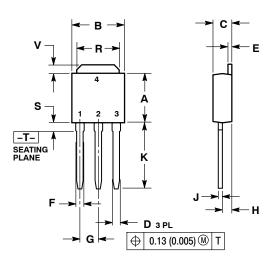
STYLE 3: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

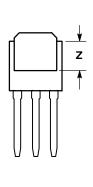
SOLDERING FOOTPRINT



PACKAGE DIMENSIONS

IPAK CASE 369D ISSUE C





- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.

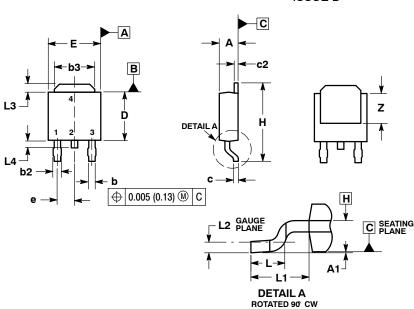
	INCHES		MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	C 2.29 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE)

CASE 369C-01 ISSUE D



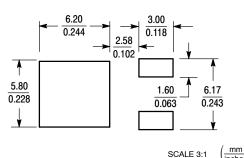
NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. CONTROLLING DIMENSION: INCHES.
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
- MENSIONS D. A3 BID E.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD
 FLASH, PROTRUSIONS, OR BURRS. MOLD
 FLASH, PROTRUSIONS, OR GATE BURRS SHALL
 NOT EXCEED 0.006 INCHES PER SIDE.
- 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PI ANF H

	INC	HES	MILLIMETER		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090 BSC		2.29	BSC	
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108	REF	F 2.74 REF		
L2	0.020 BSC		0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

- STYLE 2: PIN 1. GATE
 - 2. DRAIN
 - 3. SOURCE 4. DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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